


<b>Search Notes</b> 	<b>Application/Control No.</b> 10627269	<b>Applicant(s)/Patent Under Reexamination</b> CHEN ET AL.
	<b>Examiner</b> Patel, Hetul	<b>Art Unit</b> 2186

### SEARCHED

Class	Subclass	Date	Examiner
711	220	1/17/2008	HBP

### SEARCH NOTES

Search Notes	Date	Examiner
EAST: keyword search limited to 711/202, 712/43,208,229	1/17/2008	HBP
IEEE: keyword search	1/17/2008	HBP
EAST: Interference search only	4/21/2008	HBP

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
711	202,220	1/17/2008	HBP
712	43,208,229	1/17/2008	HBP
711	202,220	4/21/2008	HBP
712	43,208,229	4/21/2008	HBP